

Search Notes**Application/Control No.**

10/589,382

**Applicant(s)/Patent under
Reexamination**

OGATA ET AL.

Examiner

Sin J. Lee

Art Unit

1795

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EIC structure search for formula (2) compound (to be scanned soon).	10/24/2008	SJL